IN THE CLAIMS

(previously presented) A method for inspecting objects, the method comprising:
creating a reference image for a representative object, said reference image
comprising an at least partially vectorized first representation of boundaries representing said
representative object;

acquiring an image of an object under inspection comprising a second representation of boundaries representing said object under inspection; and

comparing a location of at least some boundaries in the second representation of boundaries to a location of corresponding boundaries in said at least partially vectorized first representation of boundaries, thereby to identify defects.

- 2. (previously presented) A method according to claim 1 wherein the comparing employs a user-selected variable threshold for acceptable distance between corresponding portions of the boundaries in the first and second representations.
- 3. (currently amended) A system for image processing comprising:
- a boundary identifier operative to generate a representation of boundaries of known elements in the an image;
- a hardware candidate defect identifier operative to identify at least some candidate defects in the image, in hardware; and
- a software candidate defect inspector receiving an output from the hardware candidate defect identifier and analyzing a location of boundaries in said representation of boundaries to identify at least one false alarm within said output, in software.
- 4. (original) A system according to claim 3 wherein the boundary identifier comprises a hardware boundary identifier operative to generate a representation of boundaries of known elements in the image, in hardware.

- 5. (original) A system according to claim 3 and also comprising a software candidate defect identifier operative to identify additional candidate defects in the image, in software.
- 6. (original) A system according to claim 5 wherein the software candidate defect inspector also receives a second output from the software candidate defect identifier and uses the representation of boundaries to identify at least one false alarm within said second output, in software.
- 7. (original) A system according to claim 3 wherein said hardware candidate defect identifier employs said representation of boundaries in order to identify at least some candidate defects.
- 8. (original) A system according to claim 5 wherein said software candidate defect identifier employs said representation of boundaries in order to identify at least some candidate defects.

Claims 9. – 33. (Cancelled)

- 34. (new) A system for image processing comprising:
- a boundary identifier operative to generate a representation of boundaries of known elements in an image;
- a hardware candidate defect identifier operative to identify at least some candidate defects in the image, in hardware;
- a software candidate defect identifier operative to identify at least some candidate defects in the image, in software; and
- a software candidate defect inspector receiving an output at least from the hardware candidate defect identifier and analyzing a location of boundaries in said representation of boundaries to identify at least one false alarm within said output, in software.

- 35. (new) A system according to claim 34 wherein the boundary identifier comprises a hardware boundary identifier operative to generate a representation of boundaries of known elements in the image, in hardware.
- 36. (new) A system according to claim 34 wherein the software candidate defect inspector also receives a second output from the software candidate defect identifier and uses the representation of boundaries to identify at least one false alarm within said second output, in software.
- 37. (new) A system according to claim 34 wherein said hardware candidate defect identifier employs said representation of boundaries in order to identify at least some candidate defects.
- 38. (new) A system according to claim 34 wherein said software candidate defect identifier employs said representation of boundaries in order to identify at least some candidate defects.